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Identification cards -Contactless integrated circuit(s) cards -Close-coupled cards

Part 1: Physical characteristics

by : Toshi KATO, Project Editor February 17, 1999

Contents

Page

Foreword	.iii
Introduction	.iv
1. Scope	.1
2. Normative references	.1
3. Terms and definitions	.1
4. Physical characteristics	.2
Annex A (informative) Standards compatibility	4
Annex B (informative) Surface quality for printing	.5

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Foreword

ISO (the International Organization for Standardization) and IEC (the International Electrotechnical Commission) form the specialized system for worldwide standardization. National bodies that are members of ISO or IEC participate in the development of International Standards through technical committees established by the respective organizations to deal with particular fields of technical activity. ISO and IEC technical committees collaborate in fields of mutual interest. Other international organizations, governmental and non-governmental, in liaison with ISO and IEC, also take part in the work.

In the field of information technology, ISO and IEC have established a joint technical committee, ISO/IEC JTC1. Draft International Standards adopted by the joint technical committee are circulated to national bodies for voting. Publication as an International Standard requires approval by at least 75% of the national bodies casting a vote.

International Standard ISO/IEC 10536-1 was prepared by Joint Technical Committee ISO/IEC JTC1, *Information technology*, Subcommittee SC17, *Identification cards and related devices*.

ISO/IEC 10536 consists of the following parts, under the general title *Identification* cards - Contactless integrated circuit(s) cards - Close-coupled cards:

- Part 1: Physical characteristics
- Part 2: Dimensions and location of coupling areas
- Part 3: Electronic signals and reset procedures
- Part 4: Answer to reset and transmission protocols

Annexes A and B of this part of ISO/IEC 10536 are for information only.

Introduction

ISO/IEC 10536 is one of a series of International Standards describing the parameters for identification cards as defined in ISO 7810 and the use of such cards for international interchange.

This part of ISO/IEC 10536 describes the physical characteristics of close-coupled cards.

This part of ISO/IEC 10536 does not preclude the incorporation of other standard technologies on the card, such as those referenced in the informative annex.

Contactless Card Standards cover a variety of types as embodied in ISO/IEC 10536 (Close- coupled cards), ISO/IEC 14443 (Proximity cards), ISO/IEC 15693 (Vicinity cards). These are intended for operation when very near, nearby and at a longer distance from associated coupling devices respectively.

ISO/IEC 10536 is intended to allow operation of Close-coupled cards in the presence of other contactless cards conforming to ISO/IEC 14443 and ISO/IEC 15693 standards.

Identification cards - Contactless integrated circuit(s) cards - Close-coupled cards

Part 1: Physical characteristics

1 Scope

This part of ISO/IEC 10536 specifies the physical characteristics of a close-coupled card (CICC). It applies to identification cards of the ID-1 card type operating either in a slot or on the surface of a coupling device.

This part of ISO/IEC 10536 shall be used in conjunction with later parts of ISO/IEC 10536 which are in development.

2 Normative references

The following standards contain provisions which, through reference in this text, constitute provisions of this part of ISO/IEC 10536. At the time of publication, the editions indicated were valid. All standards are subject to revision, and parties to agreements based on this part of ISO/IEC 10536 are encouraged to investigate the possibility of applying the most recent editions of the standards listed below. Members of IEC and ISO maintain registers of currently valid International Standards.

ISO/IEC 7810, Identification cards - Physical characteristics.

ISO/IEC 10373, Identification cards - Test methods.

IEC 61000-4-2, Electromagnetic compatibility(EMC) - Part 4: Testing and measurement techniques - Section 2: Electrostatic discharge immunity test.

3 Terms and definitions

For the purposes of this part of ISO/IEC 10536, the following definitions apply:

3.1 integrated circuit(s) (IC)

electronic component(s) designed to perform processing and/or memory functions.

3.2

contactless

pertaining to the achievement of signal exchange with and supplying power to the card without the use of galvanic elements (i.e., the absence of an ohmic path from the external interfacing equipment to the integrated circuit(s) contained within the card).

3.3 contactless integrated circuit(s) card

an ID-1 card type (as specified in ISO/IEC 7810) into which integrated circuit(s) have been placed and in which communication to such integrated circuit(s) is done in a contactless manner.

3.4

close-coupled card (CICC)

an ID-1 card type into which integrated circuit(s) and coupling means have been placed and in which communication to such integrated circuit(s) is done by inductive or capacitive coupling either in a slot or on the surface of a coupling device.

3.5

close-coupled coupling device (CCD)

the reader/writer device that uses inductive coupling to provide power to the CICC, and uses inductive or capacitive coupling to control the data exchange with the CICC.

4 Physical characteristics

4.1 General

The CICC shall have physical characteristics according to the requirements specified for ID-1 cards in ISO/IEC 7810.

4.2 Dimensions

The nominal dimensions of the CICC shall be as specified in ISO/IEC 7810 for the ID-1 type cards.

4.3 Additional characteristics

4.3.1 Ultra-violet light

This part of the ISO/IEC 10536 excludes requirements for protection of the CICC against the effects of ultraviolet light levels greater than those in ordinary daylight at sea-level. Where greater protection is needed it shall be the responsibility of the card manufacturer to provide it and to state the tolerable level of ultra-violet light.

4.3.2 X-rays

The CICC shall continue to operate as intended after exposure of either face to medium-energy X-radiation, with energy in the range of 70 keV to 140 keV, of a cumulative dose of 0,1 Gy per year.

NOTE: This corresponds to approximately twice the maximum acceptable dose to which humans may be exposed annually.

4.3.3 Dynamic bending stress

The CICC shall continue to operate as intended after testing in accordance with the test methods described in ISO/IEC 10373 where the maximum deflections about the short and long cards axes are $h_wA = 20$ mm and $h_wB = 10$ mm.

4.3.4 Dynamic torsional stress

The CICC shall continue to operate as intended after testing in accordance with the test methods described in ISO/IEC 10373 where the maximum angle of rotation is $\alpha = 15^{\circ}$.

4.3.5 Alternating magnetic fields

The CICC shall continue to operate as intended after exposure, in any orientation, to a magnetic field with an average level given in the Table 1. The averaging time is 6 minutes and the maximum rms level of the magnetic field is limited to 33 times the average level.

Tuble 1 magnetio Field Ottength Vo Frequency		
Frequency Range (MHz)	Average Magnetic Field Strength (A/m rms)	
0,3 - 3,0	1,63	
3,0 - 30	4,89/f	
30 - 300	0,163	

Table 1 - Magnetic Field Strength vs Frequency

f - frequency in MHz

4.3.6 Alternating electric field

The CICC shall continue to operate as intended after exposure, in any orientation, to an electric field with an average level given in the Table 2. The averaging time is 6 minutes and the maximum rms level of the electric field is limited to 33 times the average level.

Table 2 - Electric Field Strength vs Frequency

Frequency Range (MHz)	Average Electric Field Strength (V/m rms)
0,3 - 3,0	614
3,0 - 30	1842/f
30 - 300	61,4
f far and a state of the Miller	

f - frequency in MHz

4.3.7 Static electricity

The CICC shall continue to operate as intended after testing in accordance with the test methods described in ISO/IEC 10373 (referring to IEC 61000-4-2:1995), where the test voltage is 6 kV.

4.3.8 Static magnetic field

The CICC shall continue to operate as intended after exposure to a static 640 kA/m magnetic field.

WARNING: The data content of a magnetic stripe might be erased by such a field.

4.3.9 Operating temperature

The CICC shall operate as intended over an ambient temperature range of 0 °C to 50 °C.

Annex A

(informative)

Standards compatibility

This part of ISO/IEC 10536 does not preclude the addition of other existing card standards on the CICC, such as those listed as follows;

- ISO/IEC 7811, Identification cards Recording technique.
- ISO/IEC 7812, Identification cards Identification of issuers.
- ISO/IEC 7813, Identification cards Financial transaction cards.
- ISO/IEC 7816, Identification cards Integrated circuit(s) cards with contacts.
- ISO/IEC 14443, Identification cards Contactless integrated circuit(s) cards Proximity cards.
- ISO/IEC 15693, Identification cards Contactless integrated circuit(s) cards Vicinity cards.

Annex B

(informative)

Surface quality for printing

Where there is a requirement to customise the CICC after the manufacturing process by overprinting, care should be taken to ensure the areas used for printing are of sufficient quality appropriate to the printing technique or printer used.